Test Probe INGUN E-Type
E-075 209 064 A 2000

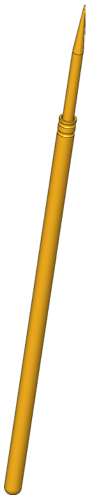
Item E-075-0032

GO TO PRODUCT

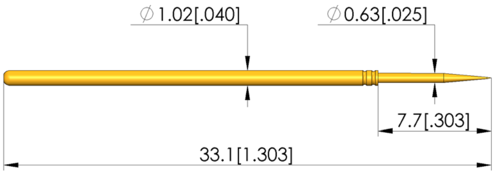
ingun®

Partner for Future Technology

- Highest contact reliability under challenging test conditions without additional stress on the DUT: up to 25% larger contact surface between test probe and DUT
- When hitting the test surface a spring force up to 100% higher than a standard GKS is available, but the same spring force as a standard GKS is achieved at the working stroke.



1:1



General data

Product group:	ICT / FCT (in-circuit test and function test
Sub-product group:	INGUN E-TYPE®
Series:	E-075
Grid:	1.91 mm [75.1 mil]
Contacting from:	Pad
Magnetic:	Yes
Installation type:	Plug-in
Quick-exchange system:	Yes
Adjustable installation height:	No
Non-rotating:	No
Compatible receptacle(s):	KS-075
Min. temperature:	-40 °C [-40 °F]
Max. temperature:	80 °C [176 °F]
RoHS-compliant:	Yes

Tip style data

Tip style:	09 flexi-needle, self-cleaning
Tip diameter:	0.64 mm [.025 in]
Tip style surface:	A gold
Tip style material:	2 steel

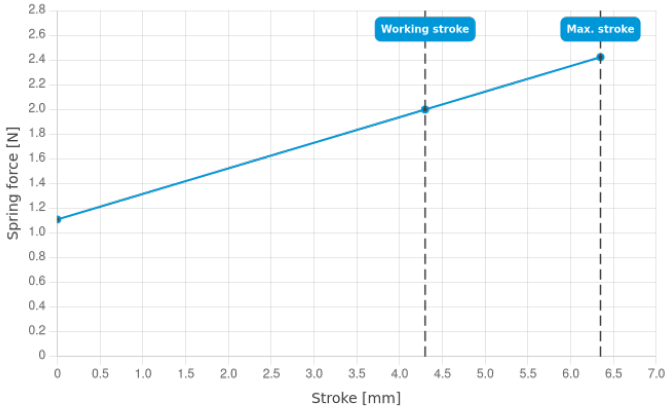
Electrical data

Current load capacity / rated current:	3 A
Typical resistance (Ri):	20 mOhm

Mechanical data

Total length:	33.1 mm [1.3 in]
Barrel diameter:	1.02 mm [.04 in]
Maximum stroke:	6.35 mm [.25 in]
Spring pre-load:	1.11 N [3.99 ozf]
Collar height:	00
Spring force at working stroke:	2 N [7.19 ozf]
Recommended working stroke:	4.3 mm [.169 in]

ICT/FCT TEST PROBES


Working stroke
Max. stroke
Spring force [N]
2.8
2.6
2.4
2.2
2.0
1.8
1.6
1.4
1.2
1.0
0.8
0.6
0.4
0.2
0
0
0.5
1.0
1.5
2.0
2.5
3.0
3.5
4.0
4.5
5.0
5.5
6.0
6.5
7.0
Stroke [mm]